Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10665770	PASRICHA, PANKAJ JAY
Examiner	Art Unit
Kim, Jennifer	1617

SEARCHED				
Class		Subclass	Date	Examiner
514	179		3/19/2007	jmk
			updated 9/30/2007	jmk
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INTERFERENCE SEARCH			
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Primary Examiner, Art Unit 1617

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